

华润微电子(重庆)有限公司

#### **Features**

- Uses CRM(CQ) advanced Trench MOS technology
- ullet Extremely low on-resistance  $R_{DS(on)}$
- Excellent  $Q_g x R_{DS(on)}$  product(FOM)
- Qualified according to JEDEC criteria

## **Applications**

- · Motor control and drive
- Battery management
- UPS (Uninterrupible Power Supplies)

## **Product Summary**

$V_{DS}$	100V
R <sub>DS(on) typ.</sub>	67mΩ
$I_{D}$	15A

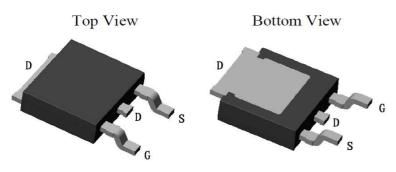
100% DVDS Tested

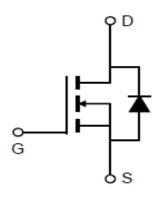
100% Avalanche Tested





#### TO-252





## **Package Marking and Ordering Information**

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRTD10DN10L	CRTD10DN10L	TO-252	Reel	N/A	N/A	2500pcs

## **Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Drain-source voltage	$V_{DS}$	100	V
Continuous drain current			
T <sub>C</sub> = 25°C (Silicon limit)	$I_{D}$	15	Α
T <sub>C</sub> = 25°C (Package limit)	ID	40	A
T <sub>C</sub> = 100°C (Silicon limit)		9	
Pulsed drain current ( $T_C = 25$ °C, $t_p$ limited by $T_{jmax}$ )	${ m I_{D~pulse}}$	60	Α
Avalanche energy, single pulse (L=0.1mH, Rg=25 $\Omega$ )	E <sub>AS</sub>	7	mJ
Gate-Source voltage	$V_{GS}$	±20	V
Power dissipation ( $T_C = 25$ °C)	P <sub>tot</sub>	40	W
Operating junction and storage temperature	$T_{j}$ , $T_{stg}$	-55+150	°C
Soldering temperature, wave soldering only allowed at leads (1.6mm from case for 10s)	T <sub>sold</sub>	260	°C

Trench N-MOSFET 100V,  $67m\Omega$ , 15A



# **Thermal Resistance**

Parameter	Symbol	Max	Unit
Thermal resistance, junction – case.	$R_{thJC}$	3.12	°C/W
Thermal resistance, junction – ambient(min. footprint)	$R_{thJA}$	105	- C/ VV

## Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

	Value						
Parameter	Symbol	min.	typ.	max.	Unit	Test Condition	
Static Characteristic							
Drain-source breakdown voltage	BV <sub>DSS</sub>	100	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	
Gate threshold voltage	V <sub>GS(th)</sub>	1.4	2	2.6	V	$V_{DS}=V_{GS}$ , $I_{D}=250$ uA	
Zero gate voltage drain current	${ m I}_{ m DSS}$	-	0.01	1 50	μΑ	$V_{DS}=100V, V_{GS}=0V$ $T_{j}=25^{\circ}C$ $T_{j}=150^{\circ}C$	
Gate-source leakage current	$I_{GSS}$	-	±10	±100	nA	VGS=±20V,VDS=0V	
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	67 150 74	100 180 110	mΩ	$V_{GS}$ =10V, $I_D$ =8A, Tj=25°C Tj=150°C $V_{GS}$ =4.5V, $I_D$ =5A,	
Transconductance	9 <sub>fs</sub>	-	22	-	S	V <sub>DS</sub> =10V,I <sub>D</sub> =8A	

# **Dynamic Characteristic**

Input Capacitance	C <sub>iss</sub>	-	596	-		
Output Capacitance	$C_{oss}$	-	36	-	pF	$V_{GS}=0V$ , $V_{DS}=50V$ ,
Reverse Transfer Capacitance	C <sub>rss</sub>	-	29	-	•	f=1MHz
Gate Total Charge	$Q_{G}$	-	15	-		
Gate-Source charge	$Q_{gs}$	-	3.0	-	nC	$V_{GS}$ =10V, $V_{DS}$ =50V, $I_{D}$ =8A, f=1MHz
Gate-Drain charge	$Q_{gd}$	-	4.5	-		
Turn-on delay time	t <sub>d(on)</sub>	-	8.5	-		$V_{GS}$ =10V, $V_{DD}$ =50V, $R_{G_{ext}}$ =2.7 $\Omega$
Rise time	t <sub>r</sub>	-	21	-	nc	
Turn-off delay time	t <sub>d(off)</sub>	-	20	-	ns	
Fall time	t <sub>f</sub>	-	30	-		
Gate resistance	$R_G$	-	2.3	-	Ω	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz







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## **Body Diode Characteristic**

Parameter	Symbol	Value		Unit	Test Condition	
Parameter	Syllibol	min.	typ.	max.	Oilit	rest condition
Body Diode Forward Voltage	$V_{SD}$	-	0.9	1.3	V	$V_{GS}$ =0V, $I_{SD}$ =8A
Body Diode Continuous Forward Current	$I_S$			15	А	Tc = 25°C
Body Diode Reverse Recovery Time	t <sub>rr</sub>	-	28	-	ns	I -8A dI/dt-100A/uc
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	-	29	-	nC	I <sub>F</sub> =8A, dI/dt=100A/μs

<sup>\*</sup>The value of  $R_{thJA}$  is measured by placing the device in a still air box which is one cubic foot.





## T : 15 C

# **Typical Performance Characteristics**

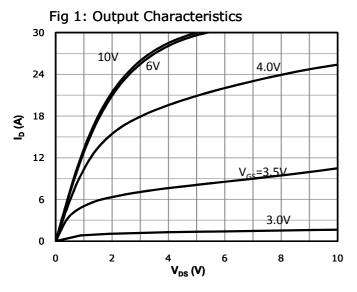
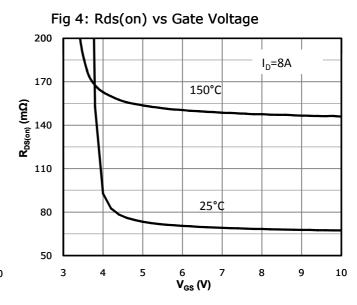


Fig 2: Transfer Characteristics 30  $V_{DS}=5V$ 24 18 **€** 12 6 150°C 25°¢ 3.0 5.0 2.0 6.0 7.0 4.0  $V_{GS}(V)$ 

Fig 3: Rds(on) vs Drain Current and Gate Voltage 140 120 R<sub>DS(on)</sub> (m<u>Q</u>)  $V_{GS} = 4.5V$ 80 V<sub>6s</sub>=10 60 40 0 4 8 12 16 20 I<sub>D</sub> (A)

Fig 5: Rds(on) vs. Temperature



3.0 V<sub>GS</sub>=10V 2.5 I<sub>D</sub>=8A 1.5 0.5 0.0

50

Tj - Junction Temperature (°C)

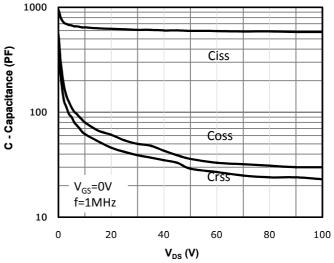
75

100

125

150

Fig 6: Capacitance Characteristics



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Fig 7: Gate Charge Characteristics

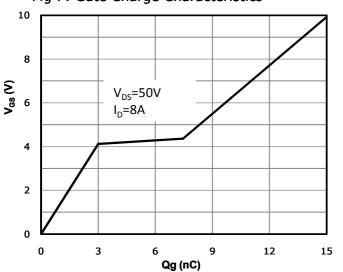


Fig 8: Body-diode Forward

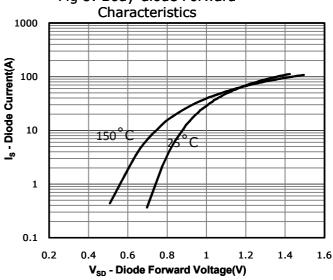


Fig 9: Power Dissipation

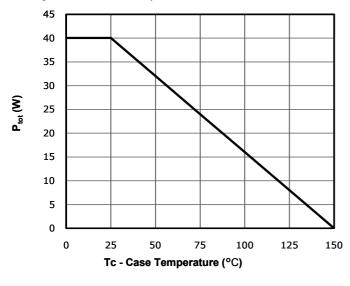


Fig 10: Drain Current Derating

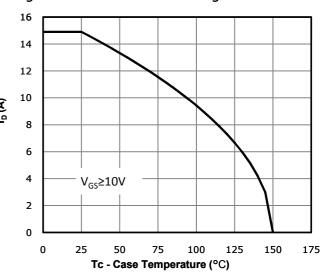


Fig 11: Safe Operating Area

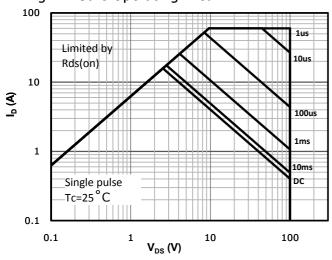
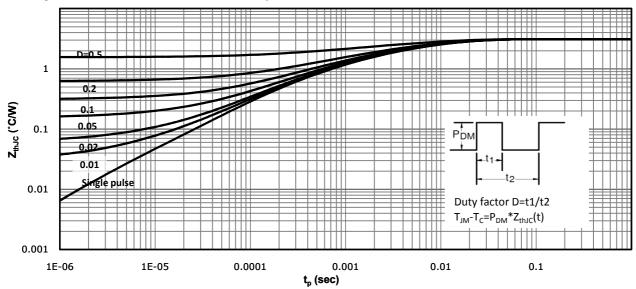




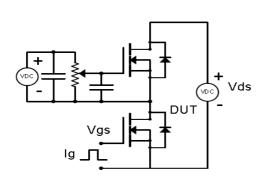
Fig 12: Max. Transient Thermal Impedance

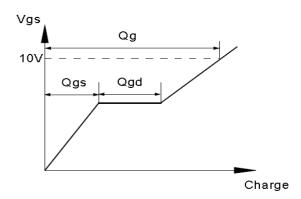




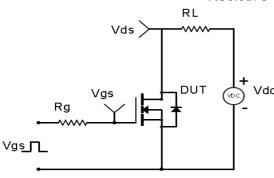
## **Test Circuit & Waveform**

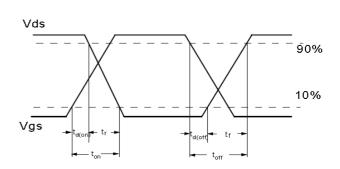
## Gate Charge Test Circuit & Waveform



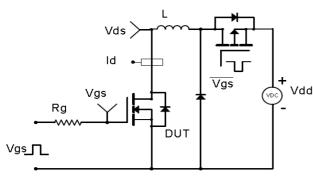


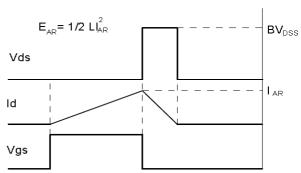
Resistive Switching Test Circuit & Waveforms



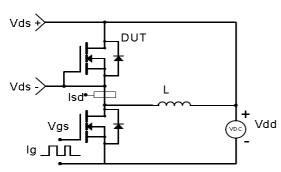


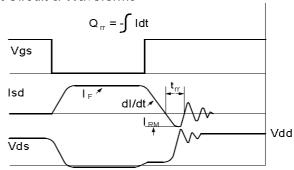
#### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



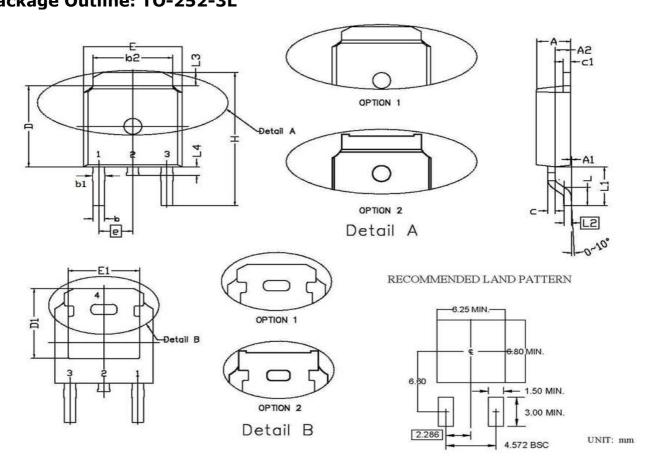


## Diode Recovery Test Circuit & Waveforms





# Package Outline: TO-252-3L



Sumb al	Dimensions I	Dimensions In Millimeters		s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	2.15	2.45	0.085	0.096
A1	0.00	0.15	0.000	0.006
A2	0.76	1.36	0.030	0.054
b	0.60	0.91	0.024	0.036
b1	0.65	1.15	0.026	0.045
b2	5.00	5.64	0.197	0.222
С	0.45	0.61	0.018	0.024
c1	0.36	0.66	0.014	0.026
D	5.80	6.30	0.228	0.248
D1	5.00	6.00	0.197	0.236
е	2.29 BSC.		0.090 BSC.	
Е	6.30	6.90	0.248	0.272
E1	4.55	5.30	0.179	0.209
Н	9.40	10.48	0.370	0.413
L	1.18	1.70	0.046	0.067
L1	2.92 REF		0.115	5 REF
L2	0.36	0.66	0.014	0.026
L3	0.72	1.35	0.028	0.053
L4	0.60	1.20	0.024	0.047





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## **Revision History**

Revison	Date	Major changes
1.0	2019/9/20	Release of formal version

#### **Disclaimer**

Unless otherwise specified in the datasheet, the product is designed and qulified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semicondutor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.